Examiner

Signature

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| INFORMATION DISCLOSURE | | | | Complete if Known | | |
|--|---|----|------|------------------------|-----------------|--|
| | | | | Application Number | 10/827,431 | |
| | | | | Filing Date | April 20, 2004 | |
| STATEMENT BY APPLICANT (use as many sheets as necessary) | | | _ | First Named Inventor | Koichiro TANAKA | |
| | | | ary) | Group Art Unit | 2872 | |
| | | | | Examiner Name | J. Phan | |
| Sheet | 1 | of | 1 | Attorney Docket Number | 0756-7285 | |

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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

/James Phan/ (02/06/2008)

Date

Considered

02/06/2008